

MJE5850, MJE5851, MJE5852

SWITCHMODE Series PNP Silicon Power Transistors

The MJE5850, MJE5851 and the MJE5852 transistors are designed for high-voltage, high-speed, power switching in inductive circuits where fall time is critical. They are particularly suited for line operated SWITCHMODE applications.

Features

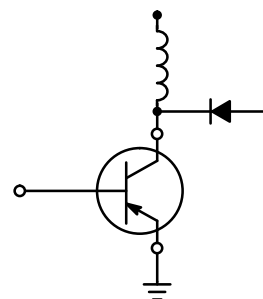
- Switching Regulators
- Inverters
- Solenoid and Relay Drivers
- Motor Controls
- Deflection Circuits
- Fast Turn-Off Times
 - ♦ 100 ns Inductive Fall Time @ 25°C (Typ)
 - ♦ 125 ns Inductive Crossover Time @ 25°C (Typ)
- Operating Temperature Range -65 to +150°C
- 100°C Performance Specified for:
 - ♦ Reversed Biased SOA with Inductive Loads
 - ♦ Switching Times with Inductive Loads
 - ♦ Saturation Voltages
 - ♦ Leakage Currents
- Pb-Free Packages are Available*



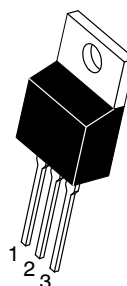
ON Semiconductor®

<http://onsemi.com>

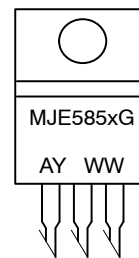
**8 AMPERE
PCP SILICON
POWER TRANSISTORS
300-350-400 VOLTS
80 WATTS**



MARKING DIAGRAM



TO-220AB
CASE 221A-09
STYLE 1



MJE585x	=	Device Code
x	=	0, 1, or 2
G	=	Pb-Free Package
A	=	Assembly Location
Y	=	Year
WW	=	Work Week

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

MJE5850, MJE5851, MJE5852

MAXIMUM RATINGS

Rating	Symbol	MJE5850	MJE5851	MJE5852	Unit
Collector–Emitter Voltage	V _{CEO(sus)}	300	350	400	Vdc
Collector–Emitter Voltage	V _{CEV}	350	400	450	Vdc
Emitter Base Voltage	V _{EB}	6.0			Vdc
Collector Current – Continuous – Peak (Note 1)	I _C I _{CM}	8.0 1 6			Adc
Base Current – Continuous – Peak (Note 1)	I _B I _{BM}	4.0 8.0			Adc
Total Power Dissipation @ T _C = 25°C Derate above 25°C	P _D	80 0.640			W W/°C
Operating and Storage Junction Temperature Range	T _J , T _{stg}	–65 to 150			°C

THERMAL CHARACTERISTICS

Rating	Symbol	Max	Unit
Thermal Resistance, Junction–to–Case	$R_{\theta JC}$	1.25	$^\circ\text{C/W}$
Maximum Lead Temperature for Soldering Purposes: 1/8" from Case for 5 Seconds	T_L	275	$^\circ\text{C}$

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Pulse Test: Pulse Width = 5 ms, Duty Cycle $\leq 10\%$.

ORDERING INFORMATION

Device	Package	Shipping
MJE5850	TO–220	50 Units / Rail
MJE5850G	TO–220 (Pb–Free)	
MJE5851	TO–220	
MJE5851G	TO–220 (Pb–Free)	
MJE5852	TO–220	
MJE5852G	TO–220 (Pb–Free)	

MJE5850, MJE5851, MJE5852

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
----------------	--------	-----	-----	-----	------

OFF CHARACTERISTICS

Collector-Emitter Sustaining Voltage (I _C = 10 mA, I _B = 0)	MJE5850 MJE5851 MJE5852	V _{CEO(sus)}	300 350 400	– – –	Vdc
Collector Cutoff Current (V _{CEV} = Rated Value, V _{BE(off)} = 1.5 Vdc) (V _{CEV} = Rated Value, V _{BE(off)} = 1.5 Vdc, T _C = 100°C)		I _{CEV}	– –	– –	0.5 2.5 mAdc
Collector Cutoff Current (V _{CE} = Rated V _{CEV} , R _{BE} = 50 Ω, T _C = 100°C)		I _{CER}	–	–	3.0 mAdc
Emitter Cutoff Current (V _{EB} = 6.0 Vdc, I _C = 0)		I _{EBO}	–	–	1.0 mAdc

SECOND BREAKDOWN

Second Breakdown Collector Current with base forward biased	I _{S/b}	See Figure 12
Clamped Inductive SOA with base reverse biased	RBSOA	See Figure 13

ON CHARACTERISTICS (Note 2)

DC Current Gain (I _C = 2.0 Adc, V _{CE} = 5 Vdc) (I _C = 5.0 Adc, V _{CE} = 5 Vdc)	h _{FE}	15 5	– –	– –	–
Collector-Emitter Saturation Voltage (I _C = 4.0 Adc, I _B = 1.0 Adc) (I _C = 8.0 Adc, I _B = 3.0 Adc) (I _C = 4.0 Adc, I _B = 1.0 Adc, T _C = 100°C)	V _{CE(sat)}	– – –	– – –	2.0 5.0 2.5	Vdc
Base-Emitter Saturation Voltage (I _C = 4.0 Adc, I _B = 1.0 Adc) (I _C = 4.0 Adc, I _B = 1.0 Adc, T _C = 100°C)	V _{BE(sat)}	– –	– –	1.5 1.5	Vdc

DYNAMIC CHARACTERISTICS

Output Capacitance (V _{CB} = 10 Vdc, I _E = 0, f _{test} = 1.0 kHz)	C _{ob}	–	270	–	pF
---	-----------------	---	-----	---	----

SWITCHING CHARACTERISTICS

Resistive Load (Table 1)						
Delay Time	(V _{CC} = 250 Vdc, I _C = 4.0 A, I _{B1} = 1.0 A, t _p = 50 μs, Duty Cycle ≤ 2%)	t _d	–	0.025	0.1	μs
Rise Time		t _r	–	0.100	0.5	μs
Storage Time	(V _{CC} = 250 Vdc, I _C = 4.0 A, I _{B1} = 1.0 A, V _{BE(off)} = 5 Vdc, t _p = 50 μs, Duty Cycle ≤ 2%)	t _s	–	0.60	2.0	μs
Fall Time		t _f	–	0.11	0.5	μs
Inductive Load, Clamped (Table 1)						
Storage Time	(I _{CM} = 4 A, V _{CEM} = 250 V, I _{B1} = 1.0 A, V _{BE(off)} = 5 Vdc, T _C = 100°C)	t _{sv}	–	0.8	3.0	μs
Crossover Time		t _c	–	0.4	1.5	μs
Fall Time		t _{fi}	–	0.1	–	μs
Storage Time	(I _{CM} = 4 A, V _{CEM} = 250 V, I _{B1} = 1.0 A, V _{BE(off)} = 5 Vdc, T _C = 25°C)	t _{sv}	–	0.5	–	μs
Crossover Time		t _c	–	0.125	–	μs
Fall Time		t _{fi}	–	0.1	–	μs

2. Pulse Test: PW = 300 μs. Duty Cycle ≤ 2%

TYPICAL ELECTRICAL CHARACTERISTICS

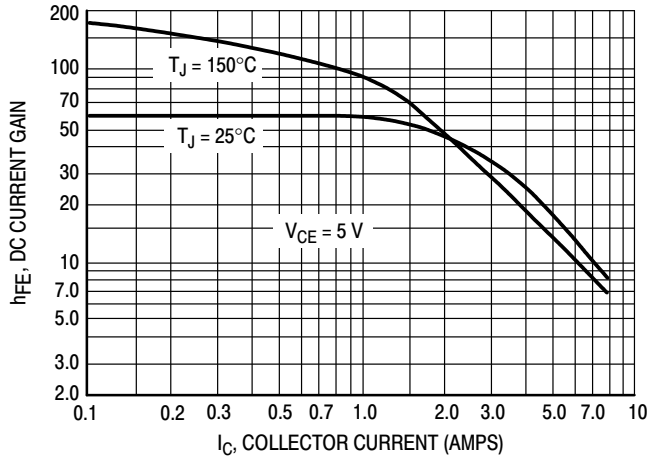


Figure 1. DC Current Gain

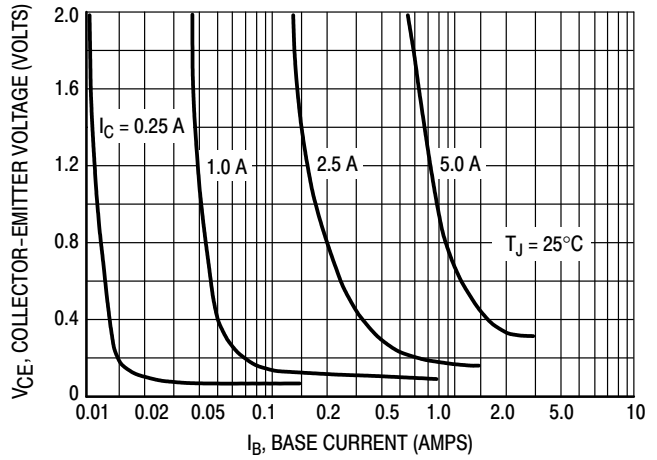


Figure 2. Collector Saturation Region

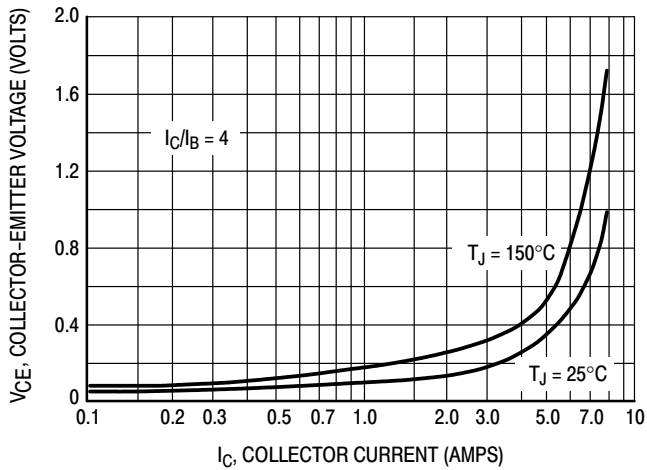


Figure 3. Collector-Emitter Saturation Voltage

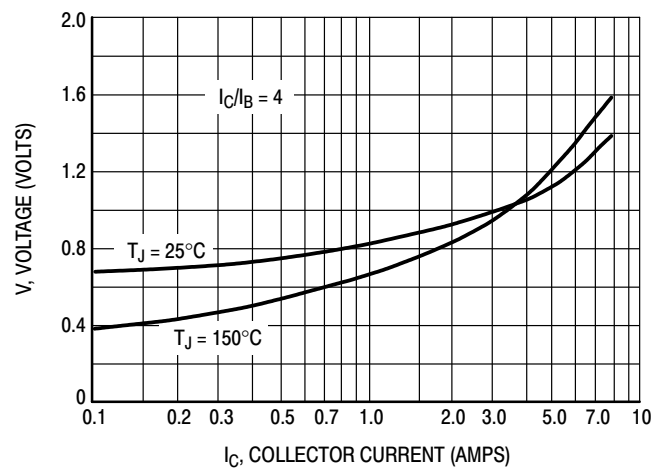


Figure 4. Base-Emitter Voltage

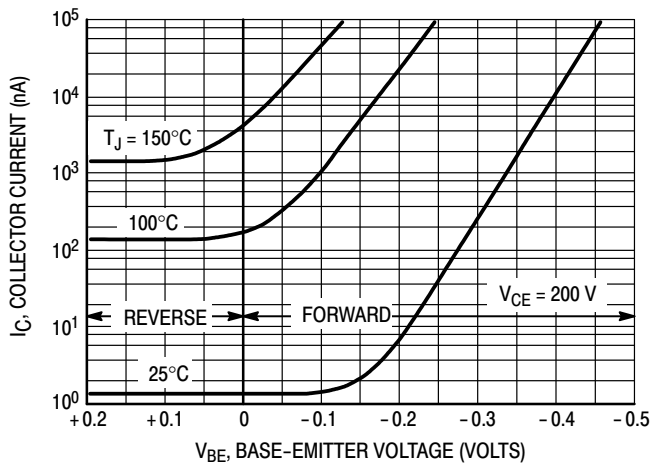


Figure 5. Collector Cutoff Region

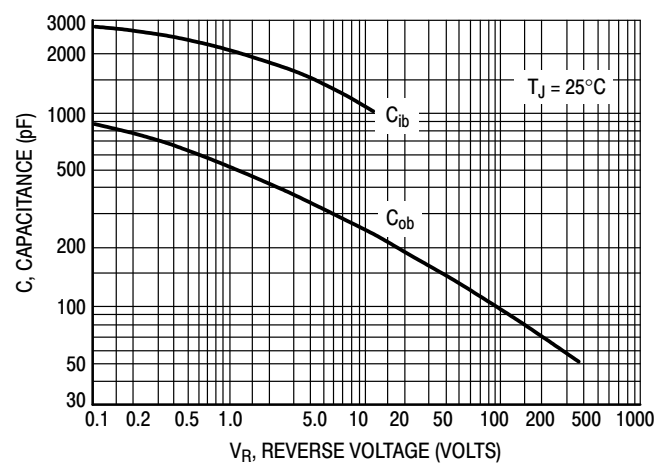


Figure 6. Capacitance

MJE5850, MJE5851, MJE5852

Table 1. Test Conditions for Dynamic Performance

	$V_{CEO(sus)}$	RBSOA AND INDUCTIVE SWITCHING	RESISTIVE SWITCHING
INPUT CONDITIONS	PW Varied to Attain $I_C = 100 \text{ mA}$	$-V$ adjusted to obtain desired I_{B1} $+V$ adjusted to obtain desired $V_{BE(off)}$	TURN-ON TIME I_{B1} adjusted to obtain the forced h_{FE} desired TURN-OFF TIME Use inductive switching driver as the input to the resistive test circuit.
CIRCUIT VALUES	$L_{coil} = 80 \text{ mH}$, $V_{CC} = 10 \text{ V}$ $R_{coil} = 0.7 \Omega$	$L_{coil} = 180 \mu\text{H}$ $R_{coil} = 0.05 \Omega$ $V_{CC} = 20 \text{ V}$ $V_{clamp} = 250 \text{ V}$ R_B adjusted to attain desired I_{B1}	$V_{CC} = 250 \text{ V}$ $R_L = 62 \Omega$ Pulse Width = $10 \mu\text{s}$
TEST CIRCUITS	INDUCTIVE TEST CIRCUIT SEE ABOVE FOR DETAILED CONDITIONS	OUTPUT WAVEFORMS t_1 Adjusted to Obtain I_C $t_1 \approx \frac{L_{coil} (I_{CM})}{V_{CC}}$ $t_2 \approx \frac{L_{coil} (I_{CM})}{V_{Clamp}}$ Test Equipment Scope — Tektronix 475 or Equivalent	RESISTIVE TEST CIRCUIT

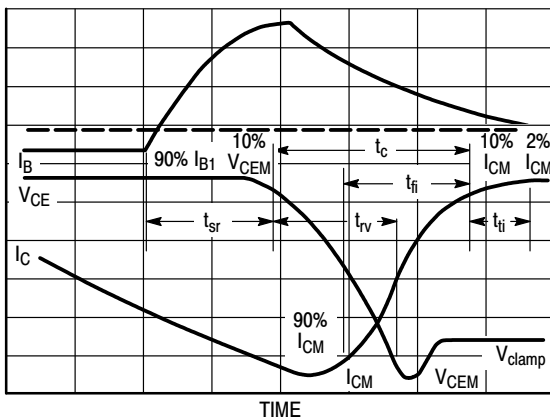


Figure 7. Inductive Switching Measurements

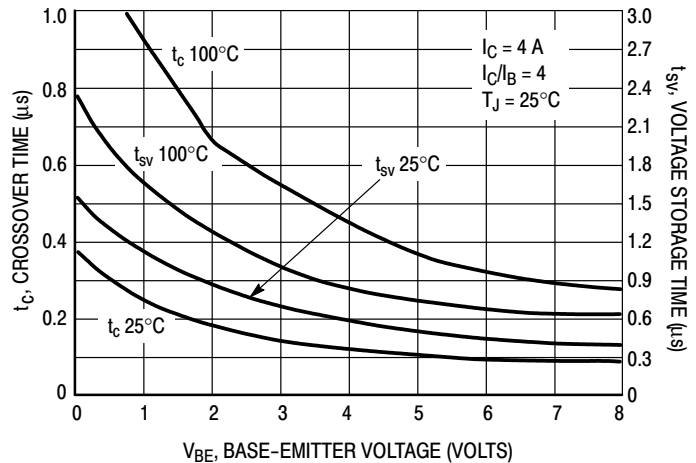


Figure 8. Inductive Switching Times

SWITCHING TIMES NOTE

In resistive switching circuits, rise, fall, and storage times have been defined and apply to both current and voltage waveforms since they are in phase. However, for inductive loads which are common to SWITCHMODE power supplies and hammer drivers, current and voltage waveforms are not in phase. Therefore, separate measurements must be made on each waveform to determine the total switching time. For this reason, the following new terms have been defined.

t_{SV} = Voltage Storage Time, 90% I_{B1} to 10% V_{CEM}

t_{RV} = Voltage Rise Time, 10–90% V_{CEM}

t_{fi} = Current Fall Time, 90–10% I_{CM}

t_{ti} = Current Tail, 10–2% I_{CM}

t_c = Crossover Time, 10% V_{CEM} to 10% I_{CM}

An enlarged portion of the inductive switching waveform is shown in Figure 7 to aid on the visual identity of these terms.

For the designer, there is minimal switching loss during storage time and the predominant switching power losses occur during the crossover interval and can be obtained using the standard equation from AN-222A:

$$P_{SWT} = 1/2 V_{CC} I_C (t_c) f$$

In general, $t_{RV} + t_{fi} \approx t_c$. However, at lower test currents this relationship may not be valid.

As is common with most switching transistors, resistive switching is specified at 25°C and has become a benchmark for designers. However, for designers of high frequency converter circuits, the user oriented specifications which make this a “SWITCHMODE” transistor are the inductive switching speeds (t_c and t_{SV}) which are guaranteed at 100°C.

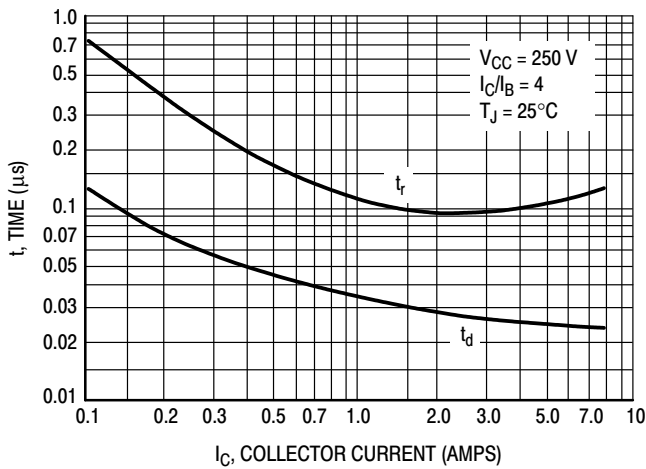


Figure 9. Turn-On Switching Times

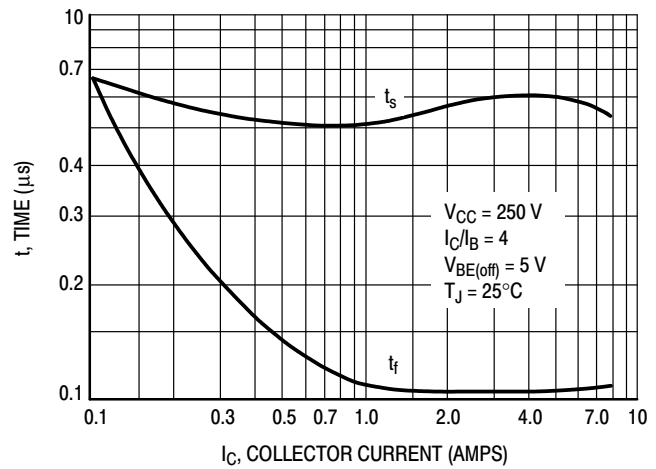


Figure 10. Turn-Off Switching Time

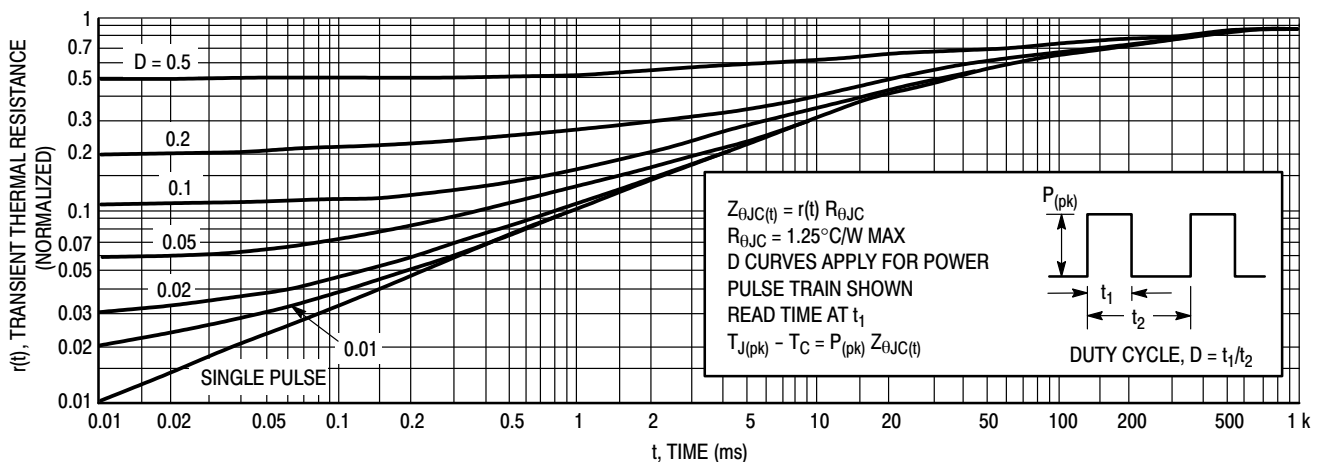


Figure 11. Typical Thermal Response $[Z_{\theta JC}(t)]$

MJE5850, MJE5851, MJE5852

The Safe Operating Area figures shown in Figures 12 and 13 are specified for these devices under the test conditions shown.

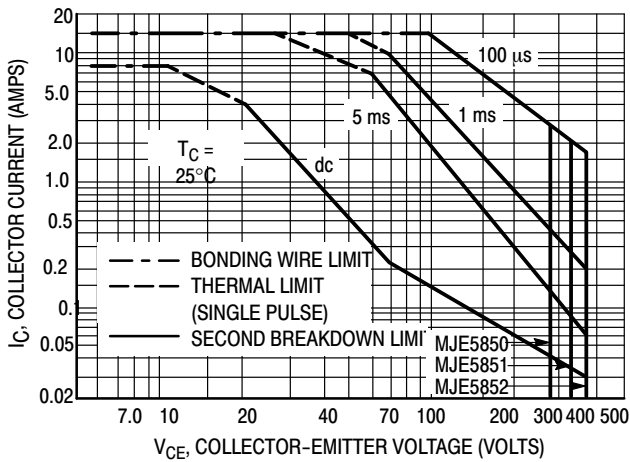


Figure 12. Maximum Forward Bias Safe Operating Area

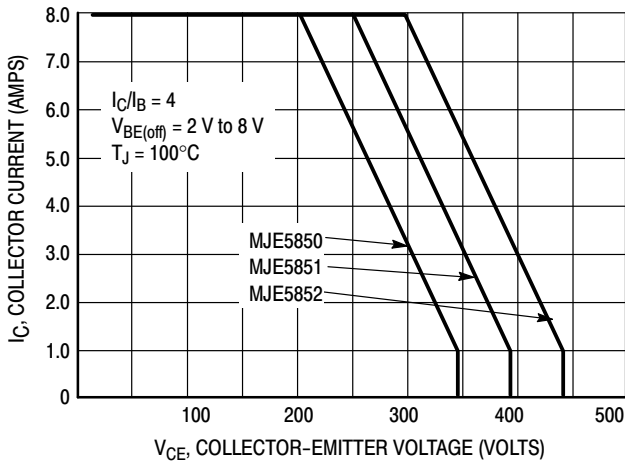


Figure 13. RBSOA, Maximum Reverse Bias Safe Operating Area

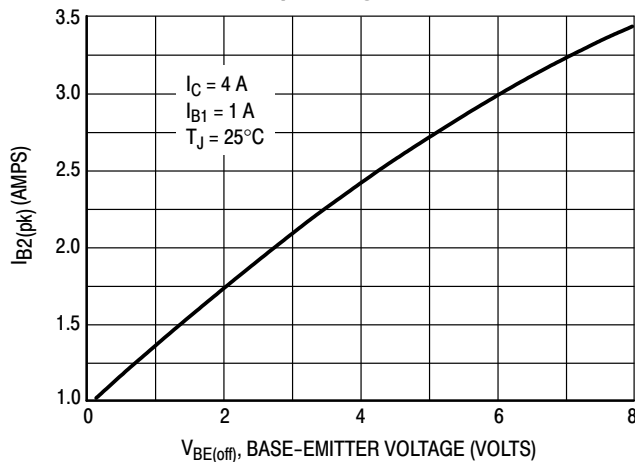


Figure 14. Peak Reverse Base Current

SAFE OPERATING AREA INFORMATION

FORWARD BIAS

There are two limitations on the power handling ability of a transistor average junction temperature and second breakdown. Safe operating area curves indicate $I_C - V_{CE}$ limits of the transistor that must be observed for reliable operation, i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figure 12 is based on $T_C = 25^\circ\text{C}$; $T_{J(pk)}$ is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated when $T_C \geq 25^\circ\text{C}$. Second breakdown limitations do not derate the same as thermal limitations. Allowable current at the voltages shown on Figure 12 may be found at any case temperature by using the appropriate curve on Figure 15.

$T_{J(pk)}$ may be calculated from the data in Figure 11. At high case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown.

REVERSE BIAS

For inductive loads, high voltage and high current must be sustained simultaneously during turn-off, in most cases, with the base to emitter junction reverse biased. Under these conditions the collector voltage must be held to a safe level at or below a specific value of collector current. This can be accomplished by several means such as active clamping, RC snubbing, load line shaping, etc. The safe level for these devices is specified as Reverse Bias Safe Operating Area and represents the voltage-current condition allowable during reverse biased turn-off. This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode. Figure 13 gives the RBSOA characteristics.

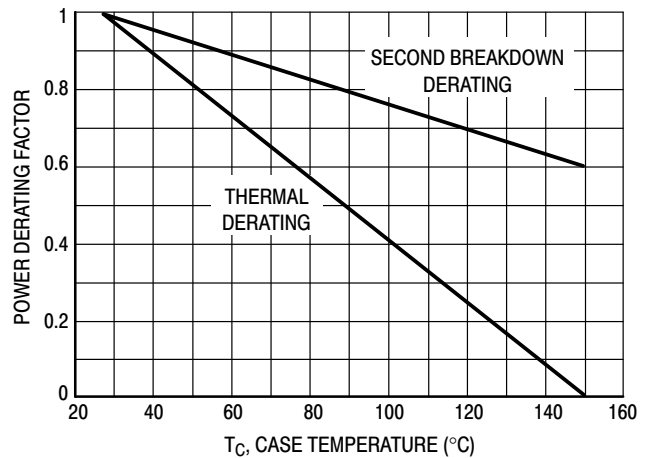
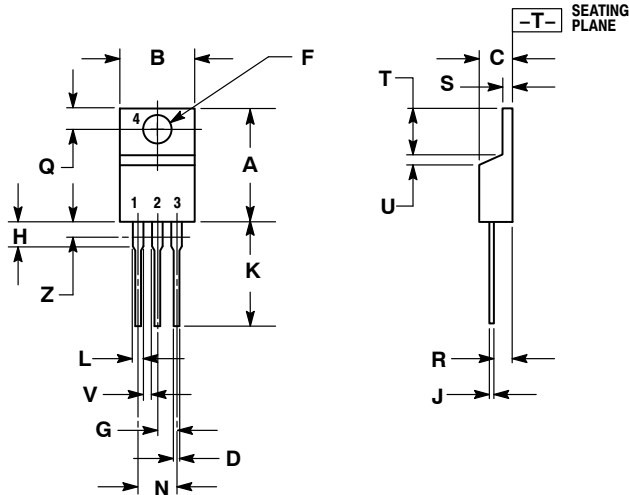


Figure 15. Forward Bias Power Derating

MJE5850, MJE5851, MJE5852

PACKAGE DIMENSIONS

TO-220
CASE 221A-09
ISSUE AG



- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.
 3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.570	0.620	14.48	15.75
B	0.380	0.405	9.66	10.28
C	0.160	0.190	4.07	4.82
D	0.025	0.036	0.64	0.91
F	0.142	0.161	3.61	4.09
G	0.095	0.105	2.42	2.66
H	0.110	0.161	2.80	4.10
J	0.014	0.025	0.36	0.64
K	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
T	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
V	0.045	---	1.15	---
Z	---	0.080	---	2.04

- STYLE 1:
- PIN 1. BASE
 - COLLECTOR
 - EMITTER
 - COLLECTOR

ON Semiconductor and  are registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:
Literature Distribution Center for ON Semiconductor
P.O. Box 5163, Denver, Colorado 80217 USA
Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada
Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada
Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free
USA/Canada
Europe, Middle East and Africa Technical Support:
Phone: 421 33 790 2910
Japan Customer Focus Center
Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com
Order Literature: <http://www.onsemi.com/orderlit>
For additional information, please contact your local Sales Representative

Данный компонент на территории Российской Федерации

Вы можете приобрести в компании MosChip.

Для оперативного оформления запроса Вам необходимо перейти по данной ссылке:

<http://moschip.ru/get-element>

Вы можете разместить у нас заказ для любого Вашего проекта, будь то серийное производство или разработка единичного прибора.

В нашем ассортименте представлены ведущие мировые производители активных и пассивных электронных компонентов.

Нашей специализацией является поставка электронной компонентной базы двойного назначения, продукции таких производителей как XILINX, Intel (ex.ALTERA), Vicor, Microchip, Texas Instruments, Analog Devices, Mini-Circuits, Amphenol, Glenair.

Сотрудничество с глобальными дистрибьюторами электронных компонентов, предоставляет возможность заказывать и получать с международных складов практически любой перечень компонентов в оптимальные для Вас сроки.

На всех этапах разработки и производства наши партнеры могут получить квалифицированную поддержку опытных инженеров.

Система менеджмента качества компании отвечает требованиям в соответствии с ГОСТ Р ИСО 9001, ГОСТ РВ 0015-002 и ЭС РД 009

Офис по работе с юридическими лицами:

105318, г.Москва, ул.Щербаковская д.3, офис 1107, 1118, ДЦ «Щербаковский»

Телефон: +7 495 668-12-70 (многоканальный)

Факс: +7 495 668-12-70 (доб.304)

E-mail: info@moschip.ru

Skype отдела продаж:

moschip.ru

moschip.ru_4

moschip.ru_6

moschip.ru_9